

SEMiX 653GD176HDc



Trench IGBT Modules

SEMiX 653GD176HDc

Preliminary Data

Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability

Typical Applications

- Matrix Converter
- Resonant Inverter
- Current Source Inverter

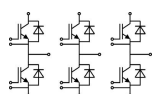
Remarks

- short circuit capability is tested @ $V_{CC}=1000V$ (all other static parameters are tested @ $V_{CC}=1200V$)

0.07"供應商

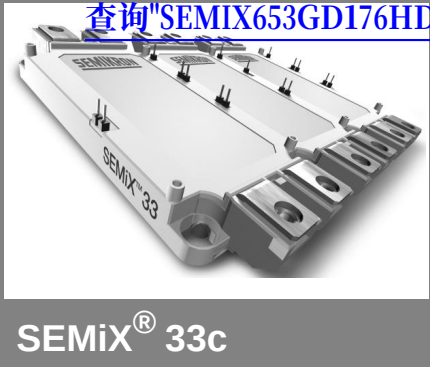
Absolute Maximum Ratings		T _{case} = 25°C, unless otherwise specified		
Symbol	Conditions	Values		Units
IGBT				
V _{CES}	T _j = 25 °C	1700		V
I _C	T _j = 150 °C	T _c = 25 °C	620	A
		T _c = 80 °C	435	A
I _{CRM}	I _{CRM} =2xI _{Cnom}	900		A
V _{GES}		± 20		V
t _{psc}	V _{CC} = 1200 V; V _{GE} ≤ 20 V; T _j = 125 °C V _{CES} < 1700 V	10		µs
Inverse Diode				
I _F	T _j = 150 °C	T _c = 25 °C	545	A
		T _c = 80 °C	365	A
I _{FRM}	I _{FRM} =2xI _{Fnom}	900		A
I _{FSM}	t _p = 10 ms; sin. T _j = 25 °C	2900		A
Module				
I _{t(RMS)}		600		A
T _{vj}		- 40 ... + 150		°C
T _{stg}		- 40 ... + 125		°C
V _{isol}	AC, 1 min.	4000		V

Characteristics		T _{case} = 25°C, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
V _{GE(th)}	V _{GE} = V _{CE} , I _C = 18 mA	5,2	5,8	6,4	V
I _{CES}	V _{GE} = 0 V, V _{CE} = V _{CES} T _j = 25 °C			0,45	mA
V _{CE0}	T _j = 25 °C T _j = 125 °C		1	1,2	V
			0,9	1,1	V
r _{CE}	V _{GE} = 0 V T _j = 25°C T _j = 125°C		2,2	2,8	mΩ
			3,4	4	mΩ
V _{CE(sat)}	I _{Cnom} = 450 A, V _{GE} = 15 V T _j = 25°C _{chiplev.} T _j = 125°C _{chiplev.}		2	2,45	V
			2,45	2,9	V
C _{ies}	V _{CE} = 25, V _{GE} = 0 V f = 1 MHz		39,6		nF
C _{oes}			1,65		nF
C _{res}			1,3		nF
Q _G	V _{GE} = -8 V ... +15 V		4200		nC
t _{d(on)}	R _{Gon} = 3,6 Ω	V _{CC} = 1200V I _{Cnom} = 450A T _j = 125 °C	290		ns
t _r			90		ns
E _{on}	300			mJ	
t _{d(off)}	975			ns	
t _f	190			ns	
E _{off}	180			mJ	
R _{th(j-c)}	per IGBT			0,054	K/W



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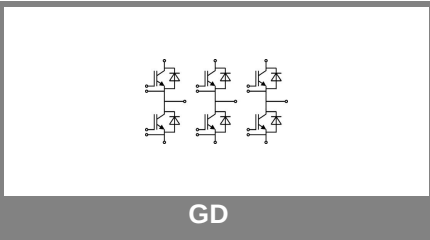
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability

Typical Applications

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Remarks

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0.7"封装

Characteristics						
Symbol	Conditions		min.	typ.	max.	Units
Inverse Diode						
$V_F = V_{EC}$	$I_{Fnom} = 450\text{ A}$; $V_{GE} = 0\text{ V}$	$T_j = 25\text{ }^{\circ}\text{C}_{chiplev.}$		1,7	1,9	V
		$T_j = 125\text{ }^{\circ}\text{C}_{chiplev.}$		1,7	1,9	V
V_{F0}		$T_j = 25\text{ }^{\circ}\text{C}$		1,1	1,3	V
		$T_j = 125\text{ }^{\circ}\text{C}$		0,9	1,1	V
r_F		$T_j = 25\text{ }^{\circ}\text{C}$		1,3		mΩ
		$T_j = 125\text{ }^{\circ}\text{C}$		1,8		mΩ
I_{RRM}	$I_{Fnom} = 450\text{ A}$	$T_j = 125\text{ }^{\circ}\text{C}$		380		A
Q_{rr}	$di/dt = 4200\text{ A}/\mu\text{s}$			130		μC
E_{rr}	$V_{GE} = -15\text{ V}$; $V_{CC} = 1200\text{ V}$			73		mJ
$R_{th(j-c)D}$	per diode				0,11	K/W
Module						
L_{CE}				20		nH
$R_{CC'+EE'}$	res., terminal-chip	$T_{case} = 25\text{ }^{\circ}\text{C}$		0,7		mΩ
		$T_{case} = 125\text{ }^{\circ}\text{C}$		1		mΩ
$R_{th(c-s)}$	per module			0,014		K/W
M_s	to heat sink M5		3		5	Nm
M_t	to terminals M6		2,5		5	Nm
w					900	g
Temperature sensor						
R_{100}	$T_c = 100^{\circ}\text{C}$ ($R_{25} = 5\text{ k}\Omega$)			0,493±5%		kΩ
$B_{100/125}$	$R(T) = R_{100} \exp[B_{100/125}(1/T - 1/T_{100})]$; $T[\text{K}]$; B			3550±2%		K

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.

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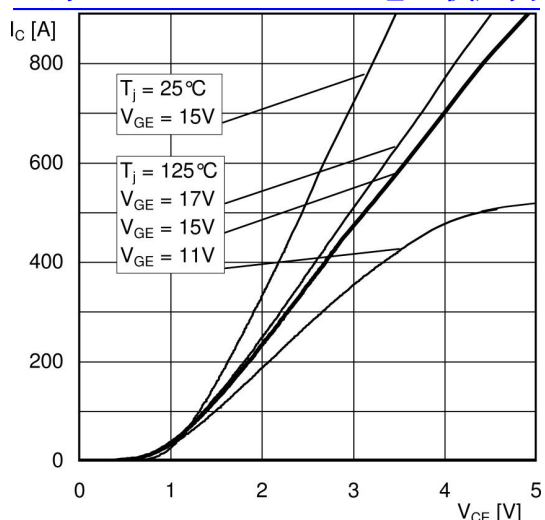


Fig. 1 Typ. output characteristic, inclusive $R_{CC'+EE'}$

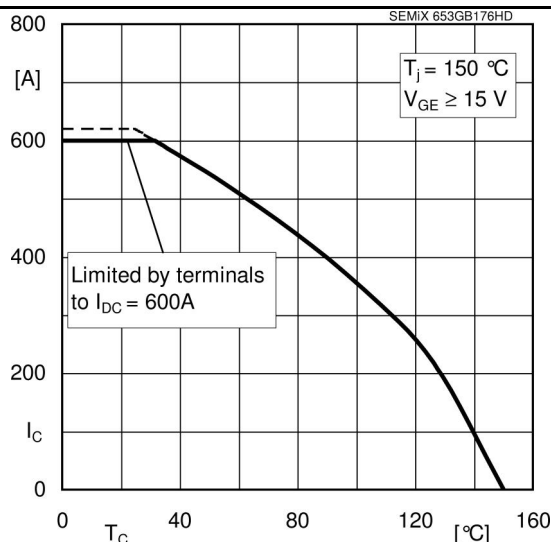


Fig. 2 Rated current vs. temperature $I_C = f(T_C)$

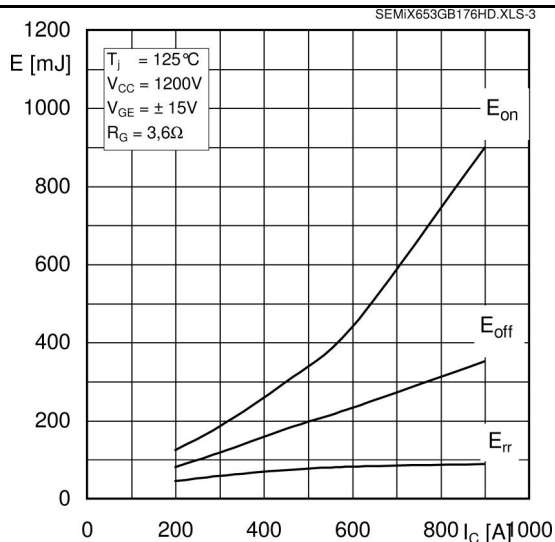


Fig. 3 Typ. turn-on /off energy = $f(I_C)$

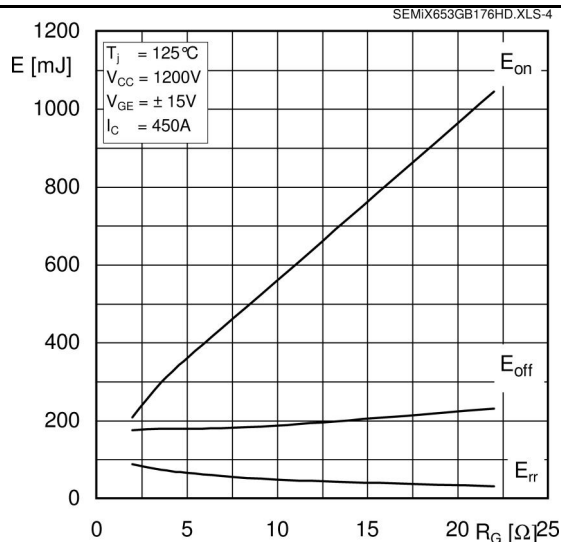


Fig. 4 Typ. turn-on /off energy = $f(R_G)$

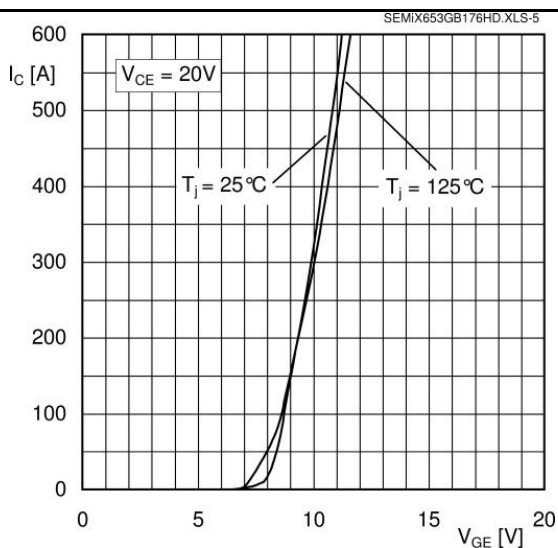


Fig. 5 Typ. transfer characteristic

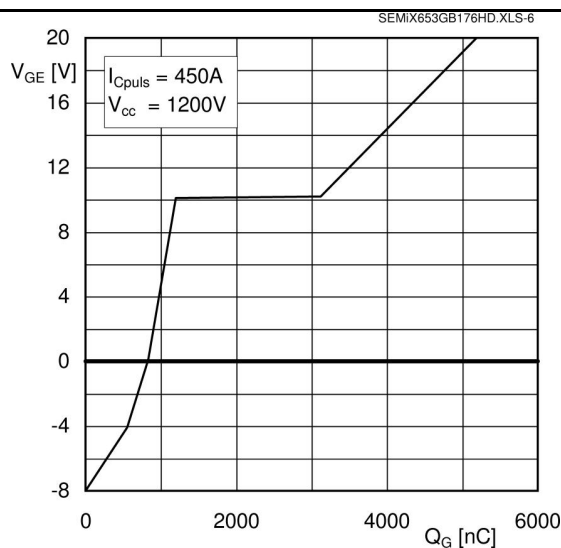


Fig. 6 Typ. gate charge characteristic

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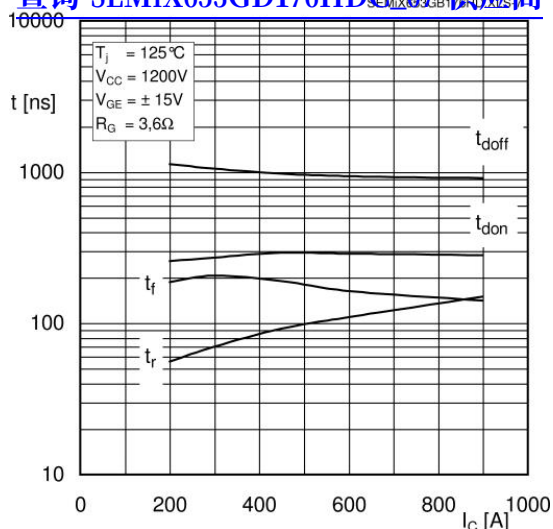


Fig. 7 Typ. switching times vs. I_C

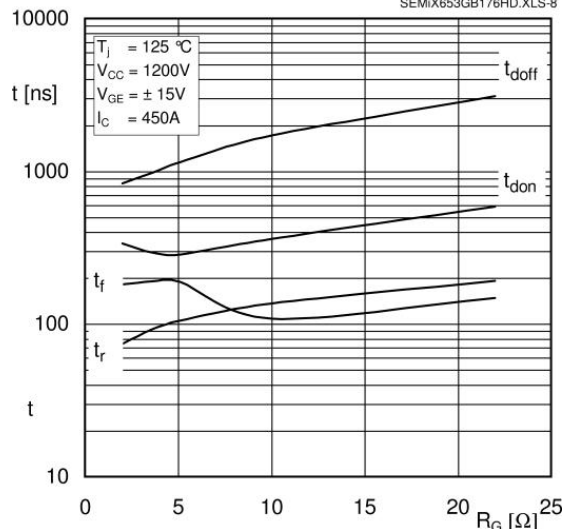


Fig. 8 Typ. switching times vs. gate resistor R_G

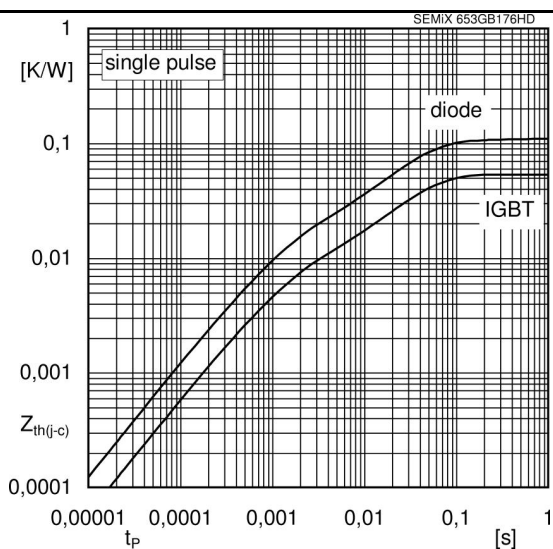


Fig. 9 Typ. transient thermal impedance

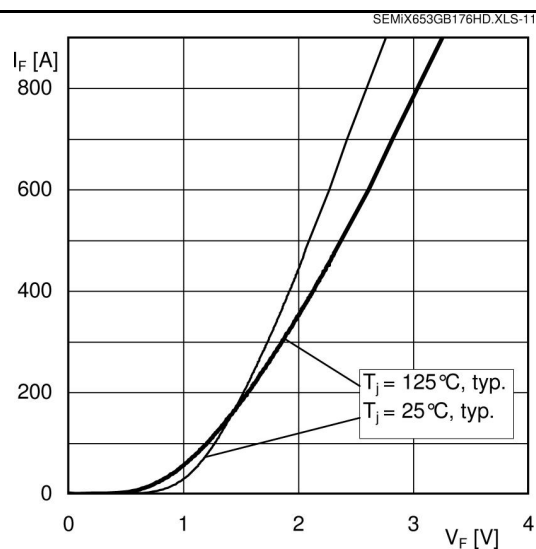


Fig. 10 Typ. CAL diode forward charact., incl. $R_{CC'+EE'}$

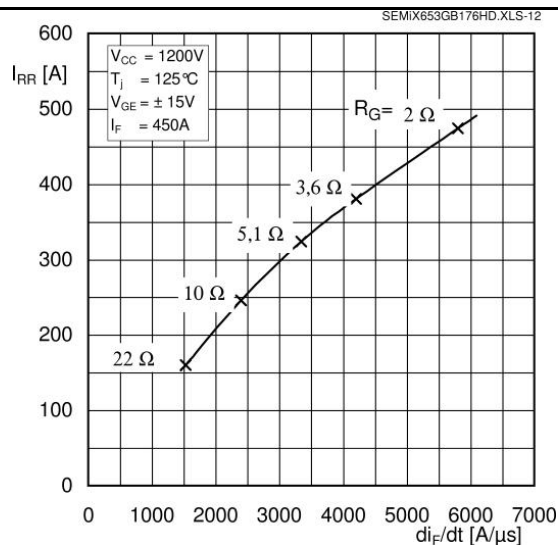


Fig. 11 Typ. CAL diode peak reverse recovery current

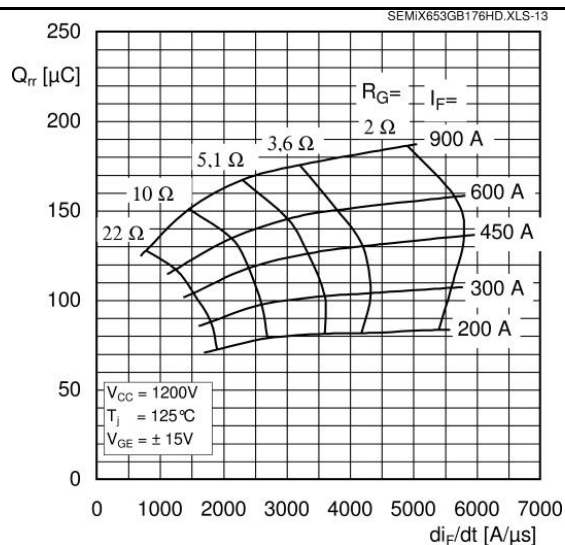
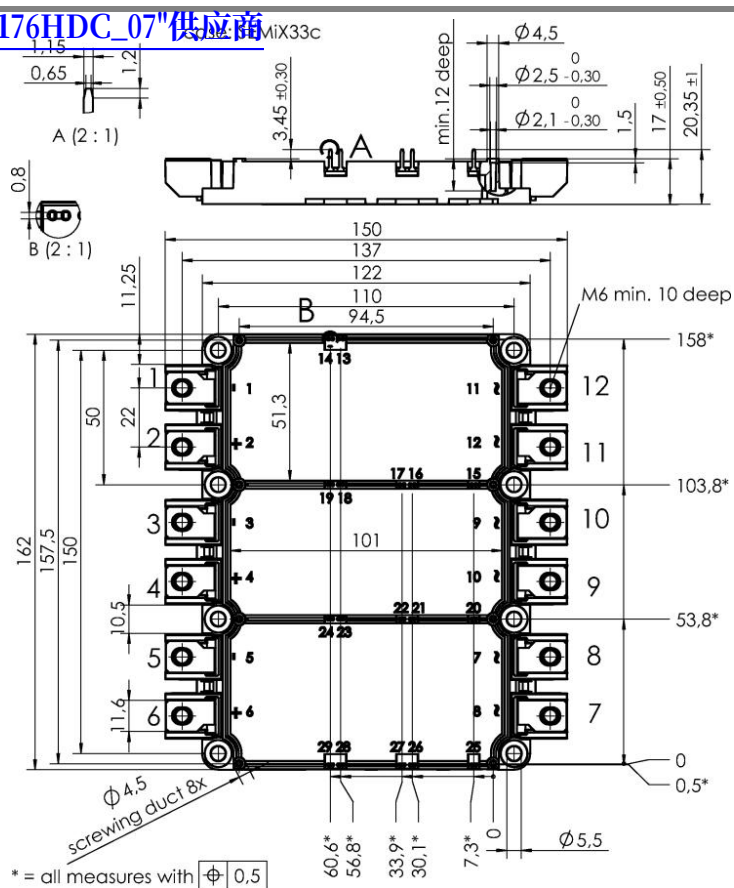


Fig. 12 Typ. CAL diode recovery charge

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Case SEMiX 33c

